CECS38N65SA

N-Channel Enhancement Mode Field Effect Transistor

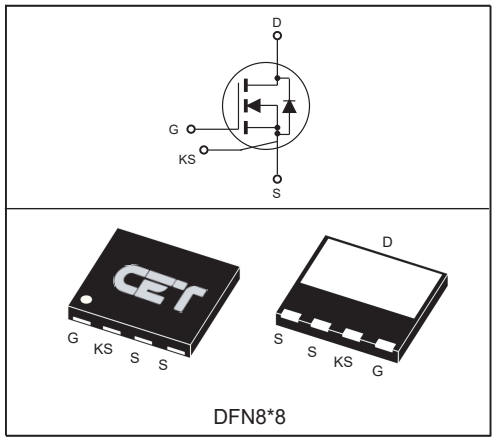
FEATURES

- High power and current handing capability.
- Reliable and rugged.
- Excellent figure of merit.
- Pb-free lead plating ; RoHS compliant.
- Halogen Free.
- 100% Avalanche tested .

APPLICATIONS

- Switching Power Supplies.
- Switching Voltage Regulators.

$V_{DSS@TJ\ max}$	$R_{DS(ON)\ typ}$	I_D	$@V_{GS}$
700V	84mΩ	37A	10V



DFN8*8

ABSOLUTE MAXIMUM RATINGS T_C = 25°C unless otherwise noted

Parameter	Symbol	Limit	Units
Drain-Source Voltage	V_{DS}	650	V
Gate-Source Voltage	V_{GS}	±30	V
Drain Current-Continuous@ T_C = 25°C	I_D	37	A
@ T_C = 70°C		30	A
Drain Current-Pulsed [a]	I_{DM}	148	A
Maximum Power Dissipation @ T_C = 25°C	P_D	338	W
- Derate above 25°C		2.7	W/°C
Single Pulsed Avalanche Energy [d]	E_{AS}	735	mJ
Single Pulsed Avalanche Current [d]	I_{AS}	7	A
Operating and Store Temperature Range	T_J,T_{stg}	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.37	°C/W

Electrical Characteristics T_C = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0V, I_D = 250μA	650			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 650V, V_{GS} = 0V			1	μA
Gate Body Leakage Current, Forward	I_{GSSF}	V_{GS} = 30V, V_{DS} = 0V			100	nA
Gate Body Leakage Current, Reverse	I_{GSSR}	V_{GS} = -30V, V_{DS} = 0V			-100	nA
On Characteristics [b]						
Gate Threshold Voltage	$V_{GS(th)}$	V_{GS} = V_{DS}, I_D = 250μA	2.5		4.5	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	V_{GS} = 10V, I_D = 10A		84	99	mΩ
Gate input resistance	R_g	f=1MHz,open Drain		3.3		Ω
Dynamic Characteristics [c]						
Input Capacitance	C_{iss}	V_{DS} = 150V, V_{GS} = 0V, f = 1.0 MHz		1915		pF
Output Capacitance	C_{oss}			110		pF
Reverse Transfer Capacitance	C_{rss}			5		pF
Switching Characteristics [c]						
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 520V, I_D =20A, V_{GS} = 10V, R_{GEN} = 6Ω		37		ns
Turn-On Rise Time	t_r			17		ns
Turn-Off Delay Time	$t_{d(off)}$			95		ns
Turn-Off Fall Time	t_f			9		ns
Total Gate Charge	Q_g	V_{DS} = 520V,I_D = 20A, V_{GS} = 10V		69		nC
Gate-Source Charge	Q_{gs}			12		nC
Gate-Drain Charge	Q_{gd}			30		nC
Drain-Source Diode Characteristics and Maximun Ratings						
Drain-Source Diode Forward Current	I_S				37	A
Drain-Source Diode Forward Voltage [b]	V_{SD}	V_{GS} = 0V, I_S = 10A [g]			1.5	V
Reverse Recovery Time	T_{rr}	V_R = 25V, I_F = 10A, dI_F /dt = 100A/us		324		ns
Reverse Recovery Charge	Q_{rr}			4.2		μC
Maximum diode commutation speed	di_F/dt	V_{DS} = 0...400V, I_{SD}< = 20A T_j = 25°C			1300	A/μs

Notes :
a.Repetitive Rating : Pulse width limited by maximum junction temperature.
b.Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
c.Guaranteed by design, not subject to production testing.
d.L = 30mH, I_{AS} =7A, V_{DD} = 60V, R_G = 25Ω, Starting T_J = 25°C.

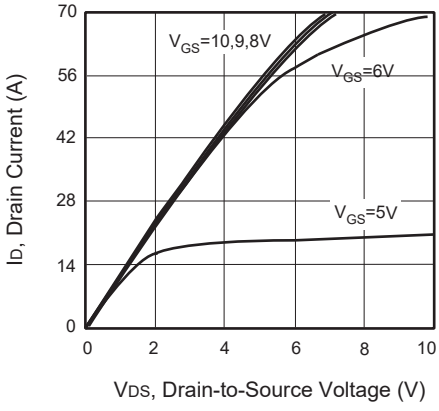


Figure 1. Output Characteristics

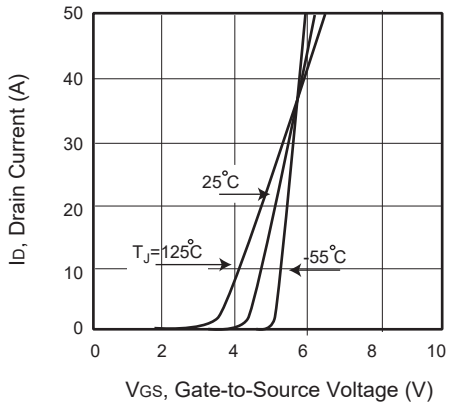


Figure 2. Transfer Characteristics

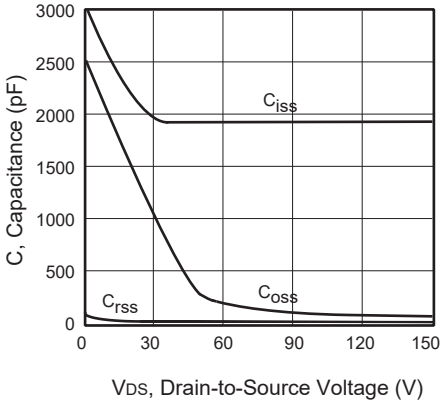


Figure 3. Capacitance

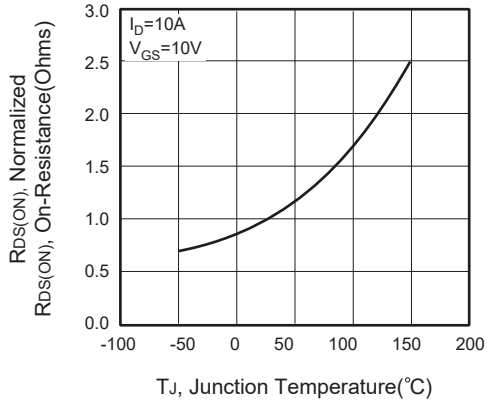


Figure 4. On-Resistance Variation with Temperature

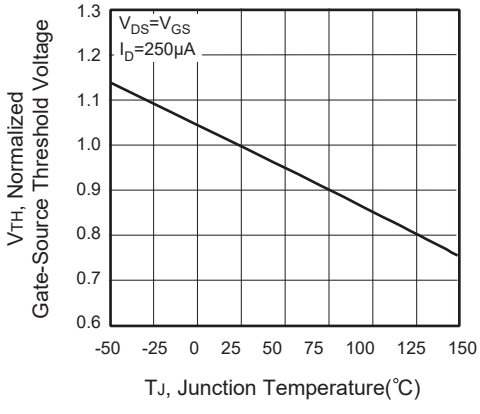


Figure 5. Gate Threshold Variation with Temperature

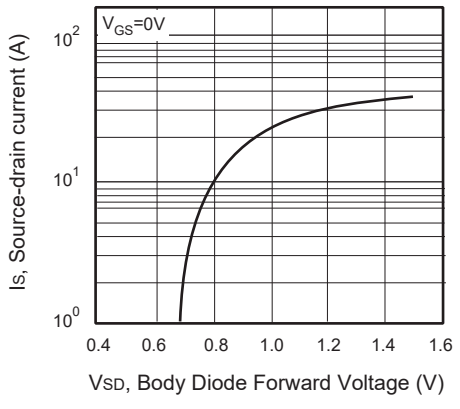


Figure 6. Body Diode Forward Voltage Variation with Source Current

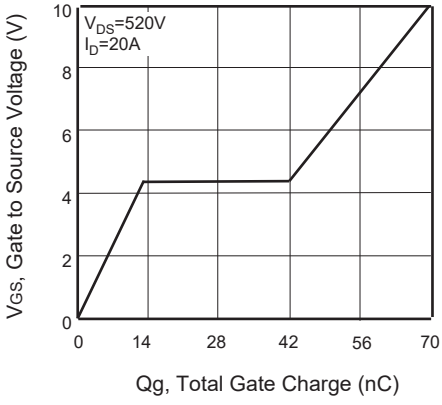


Figure 7. Gate Charge

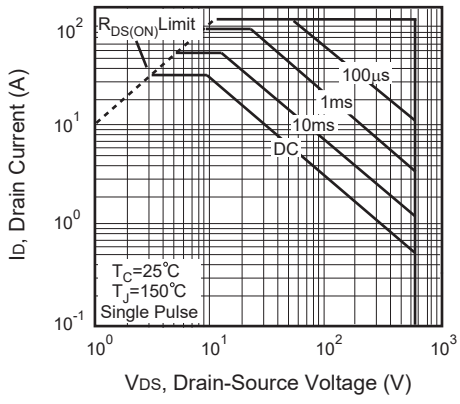


Figure 8. Maximum Safe Operating Area

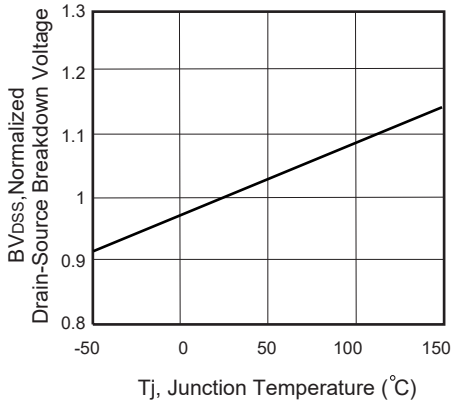


Figure 9. Breakdown Voltage Variation VS Temperature

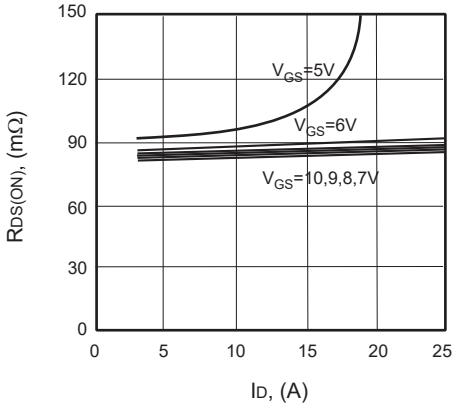


Figure 10. On-Resistance vs. Drain Current

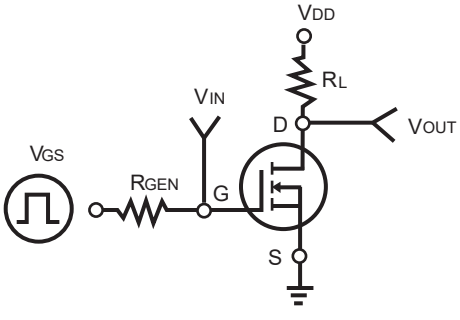


Figure 11. Switching Test Circuit

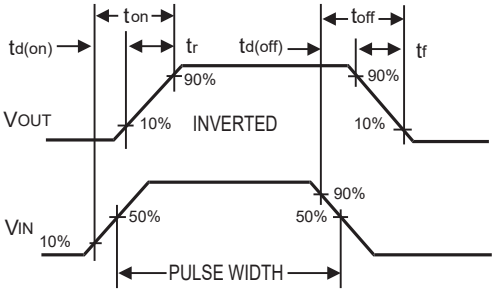


Figure 12. Switching Waveforms

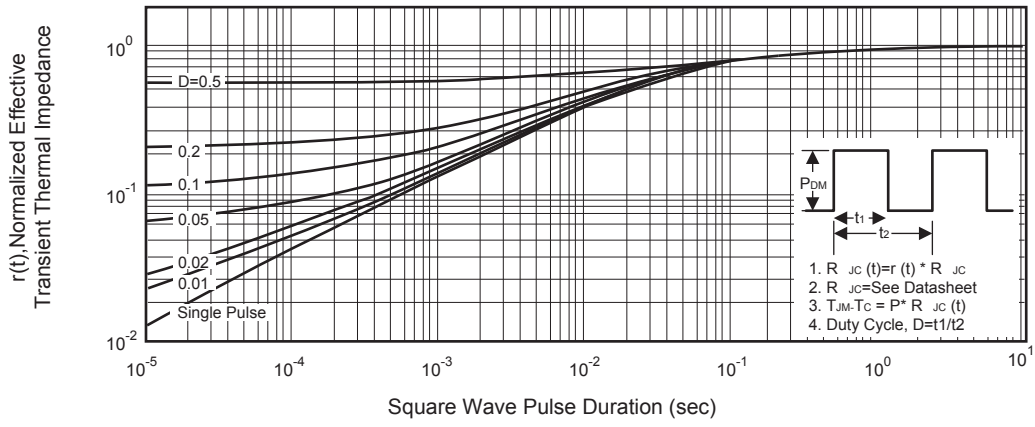


Figure 13. Normalized Thermal Transient Impedance Curve